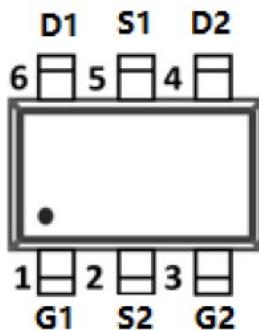
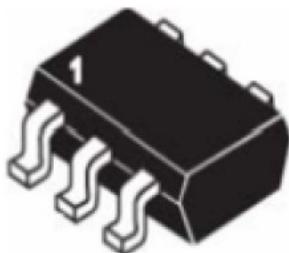


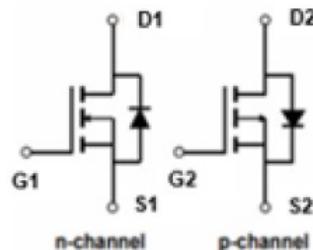


N-Channel and P-Channel Complementary Power MOSFET

Product Summary



SOT-23-6L

**NMOS**

- V_{DS} 20V
- I_D 5.6A
- $R_{DS(ON)}$ (at $VGS=4.5V$) <25mohm
- $R_{DS(ON)}$ (at $VGS=2.5V$) <32mohm
- $R_{DS(ON)}$ (at $VGS=1.8V$) <49mohm

PMOS

- V_{DS} -20V
- I_D -3.7A
- $R_{DS(ON)}$ (at $VGS=-4.5V$) <64mohm
- $R_{DS(ON)}$ (at $VGS=-2.5V$) <80mohm
- $R_{DS(ON)}$ (at $VGS=-1.8V$) <110mohm

• 100% ΔV_{DS} Tested

General Description

- Trench Power LV MOSFET technology
- High density cell design for low $R_{DS(ON)}$
- High Speed switching

Applications

- Wireless charger
- Load switch
- Power management

Absolute Maximum Ratings ($T_A=25^\circ C$ unless otherwise noted)

Parameter		Symbol	N-Channel	P-Channel	Unit
Drain-source Voltage		V_{DS}	20	-20	V
Gate-source Voltage		V_{GS}	± 10	± 10	V
Drain Current	$T_A=25^\circ C$	I_D	5.6	-3.7	A
	$T_A=70^\circ C$		4.5	-3	
Pulsed Drain Current ^A		I_{DM}	19	-15	A
Total Power Dissipation	$T_A=25^\circ C$	P_D	1.3	1.3	W
	$T_A=70^\circ C$		0.8	0.8	W
Thermal Resistance Junction-to-Ambient ^B		$R_{\theta JA}$	96	96	$^\circ C/W$
Junction and Storage Temperature Range		T_J, T_{STG}	-55~+150	-55~+150	°C

Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJS2308A	F2	2308	3000	30000	120000	7" reel



YJS2308A

■ N-MOS Electrical Characteristics ($T_J=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	20			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=20V, V_{GS}=0V$			1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 10V, V_{DS}=0V$			± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	0.5	0.62	1.0	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=4.5V, I_D=4.5A$		19.5	25	mΩ
		$V_{GS}=2.5V, I_D=3A$		25	32	
		$V_{GS}=1.8V, I_D=2A$		33	49	
Diode Forward Voltage	V_{SD}	$I_S=5.6A, V_{GS}=0V$			1.2	V
Dynamic Parameters						
Input Capacitance	C_{iss}	$V_{DS}=10V, V_{GS}=0V, f=1MHz$		418		pF
Output Capacitance	C_{oss}			82		
Reverse Transfer Capacitance	C_{rss}			70		
Switching Parameters						
Total Gate Charge	Q_g	$V_{GS}=4.5V, V_{DS}=10V, I_D=4.5A$		6.05		nC
Gate-Source Charge	Q_{gs}			1.07		
Gate-Drain Charge	Q_{gd}			1.95		
Reverse Recovery Charge	Q_{rr}	$I_F=4.5A, di/dt=100A/us$		1.38		ns
Reverse Recovery Time	t_{rr}			17.9		
Turn-on Delay Time	$t_{D(on)}$			4.2		
Turn-on Rise Time	t_r	$V_{GS}=4.5V, V_{DS}=10V, R_L=1\Omega, R_{GEN}=3\Omega$		19.8		ns
Turn-off Delay Time	$t_{D(off)}$			22.6		
Turn-off fall Time	t_f			23.2		

A. Pulse Test: Pulse Width $\leq 300\mu s$, Duty cycle $\leq 2\%$.

B. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design, while $R_{\theta JA}$ is determined by the board design. The maximum rating presented here is based on mounting on a 1 in 2 pad of 2oz copper.



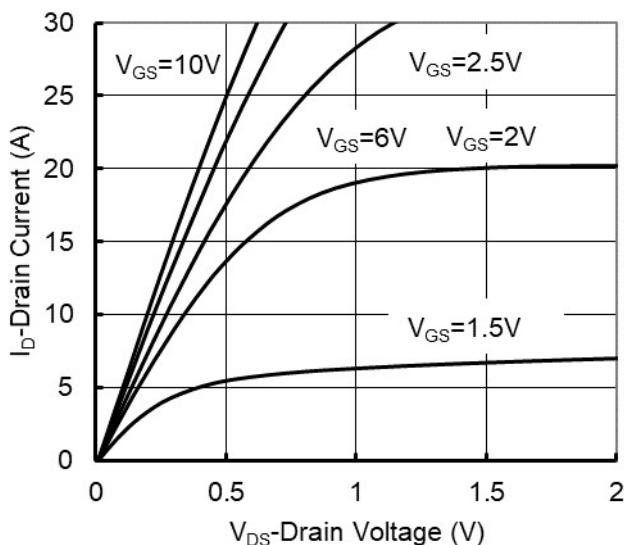
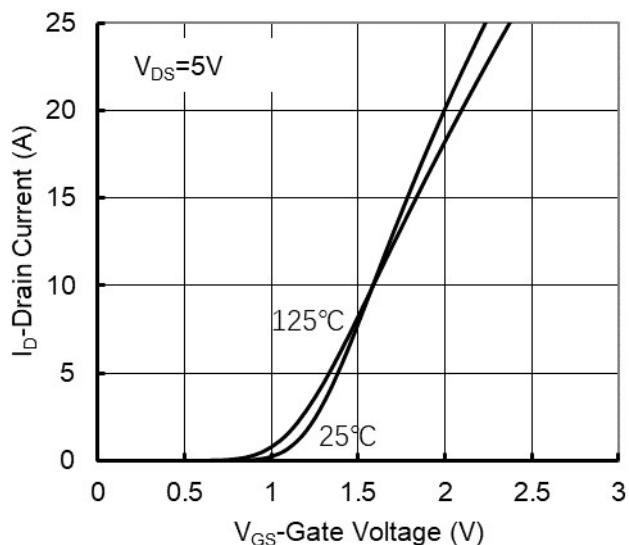
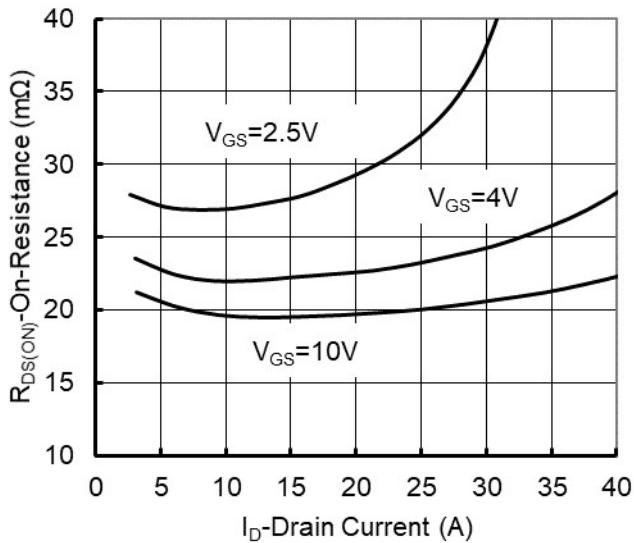
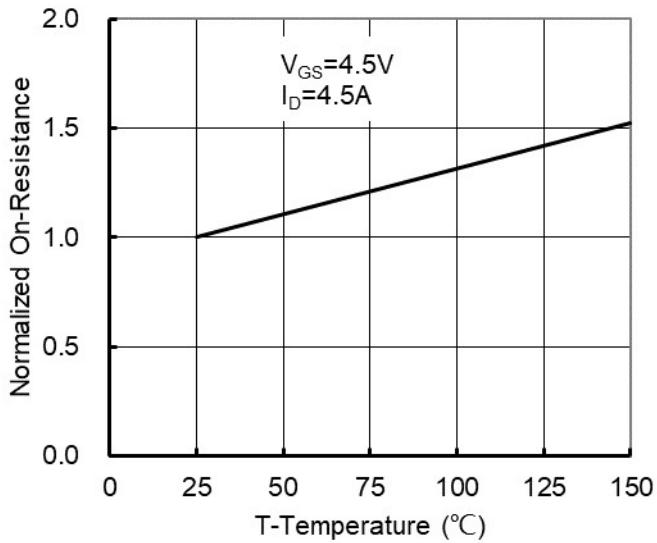
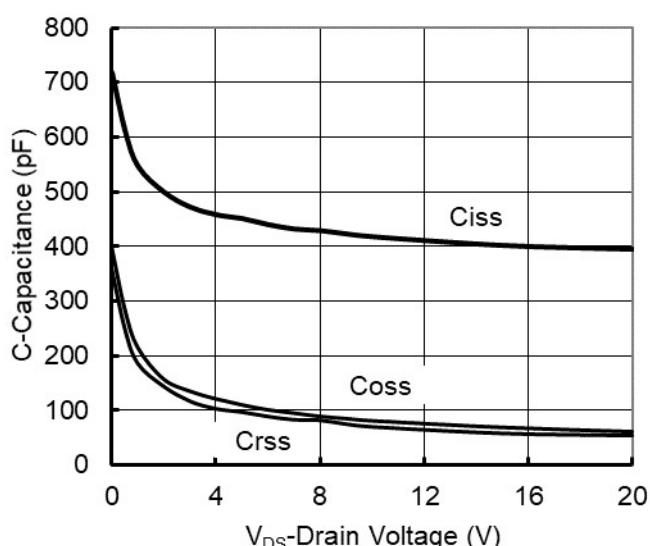
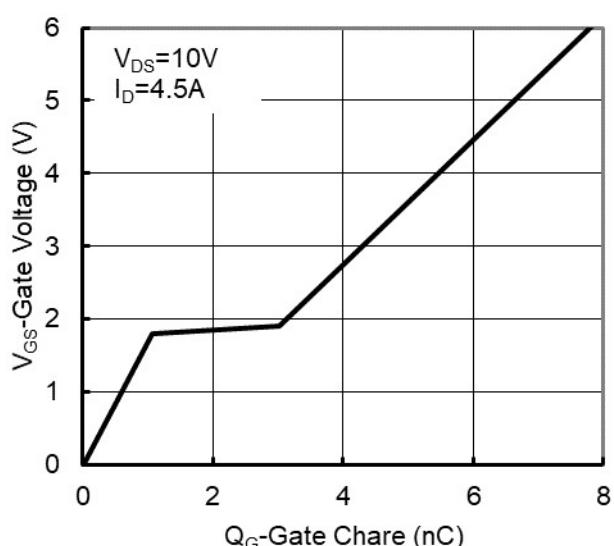
YJS2308A

■ P-MOS Electrical Characteristics ($T_J=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-20			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=-20V, V_{GS}=0V$			-1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 10V, V_{DS}=0V$			± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-0.4	-0.62	-1.0	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=-4.5V, I_D=-3.5A$		49	64	$m\Omega$
		$V_{GS}=-2.5V, I_D=-3A$		59	80	
		$V_{GS}=-1.8V, I_D=-2A$		79	110	
Diode Forward Voltage	V_{SD}	$I_S=-3.7A, V_{GS}=0V$			-1.2	V
Dynamic Parameters						
Input Capacitance	C_{iss}	$V_{DS}=-10V, V_{GS}=0V, f=1MHz$		438		pF
Output Capacitance	C_{oss}			76		
Reverse Transfer Capacitance	C_{rss}			62		
Switching Parameters						
Total Gate Charge	Q_g	$V_{GS}=-10V, V_{DS}=-15V, I_D=-3.4A$		5.41		nC
Gate-Source Charge	Q_{gs}			1.17		
Gate-Drain Charge	Q_{gd}			1.24		
Reverse Recovery Charge	Q_{rr}	$I_F=-3.4A, di/dt=100A/us$		4		ns
Reverse Recovery Time	t_{rr}			24.5		
Turn-on Delay Time	$t_{D(on)}$			6.4		
Turn-on Rise Time	t_r	$V_{GS}=-4.5V, V_{DS}=-10V, I_D=-1A$ $R_{GEN}=3\Omega$		21.8		ns
Turn-off Delay Time	$t_{D(off)}$			37.4		
Turn-off fall Time	t_f			34		

C. Pulse Test: Pulse Width $\leq 300\mu s$, Duty cycle $\leq 2\%$.

D. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design, while $R_{\theta JA}$ is determined by the board design. The maximum rating presented here is based on mounting on a 1 in 2 pad of 2oz copper.

■ N-MOS Typical Performance Characteristics

Figure1. Output Characteristics

Figure2. Transfer Characteristics

Figure 3: On-Resistance vs. Drain Current and Gate Voltage

Figure 4: On-Resistance vs. Junction Temperature

Figure5. Capacitance Characteristics

Figure6. Gate Charge

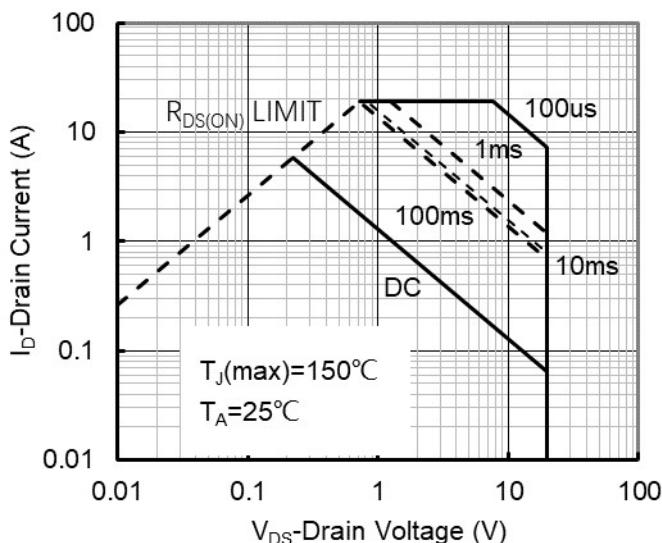


Figure 7. Safe Operation Area

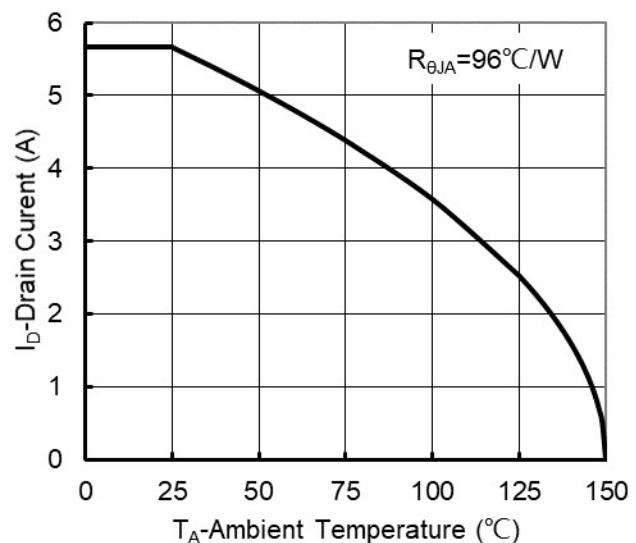


Figure 8. Maximum Continuous Drain Current vs Ambient Temperature

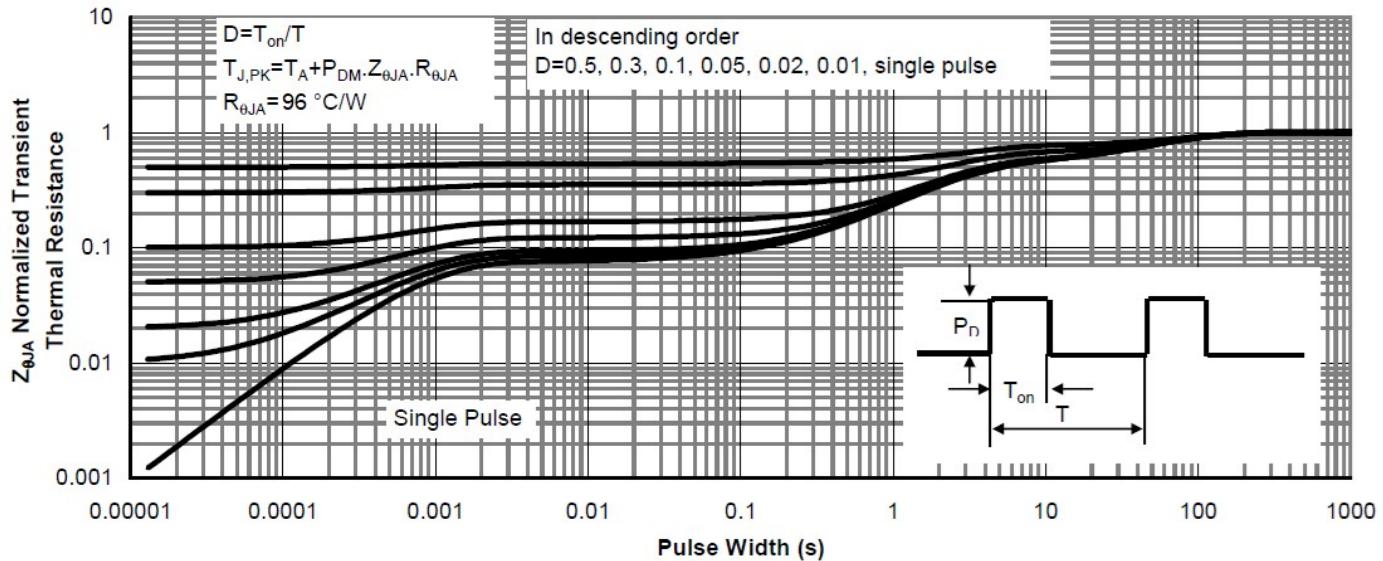


Figure 9. Normalized Maximum Transient Thermal Impedance

■ P-MOS Typical Performance Characteristics

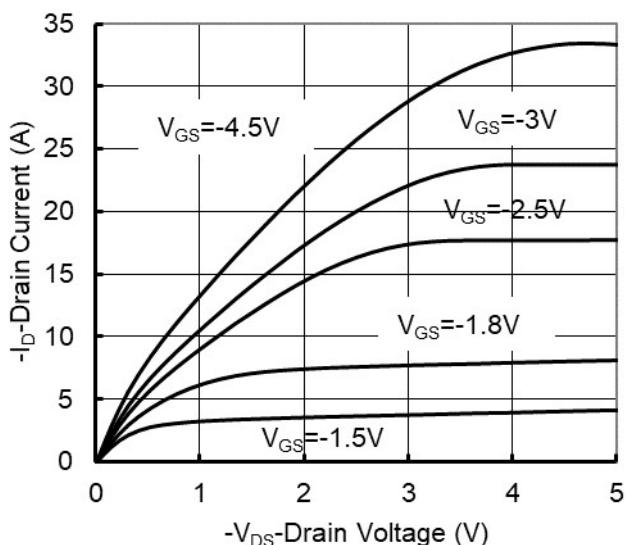


Figure 1. Output Characteristics

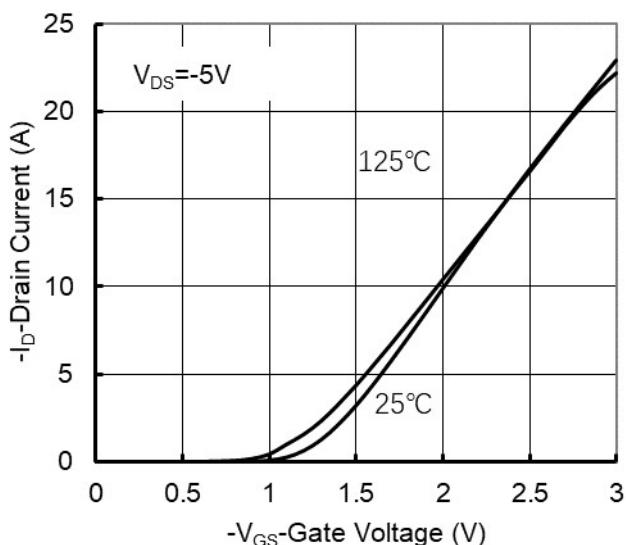


Figure 2. Transfer Characteristics

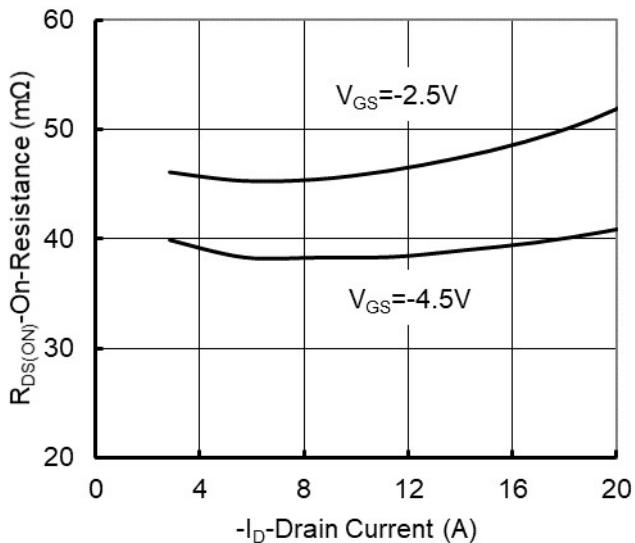


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

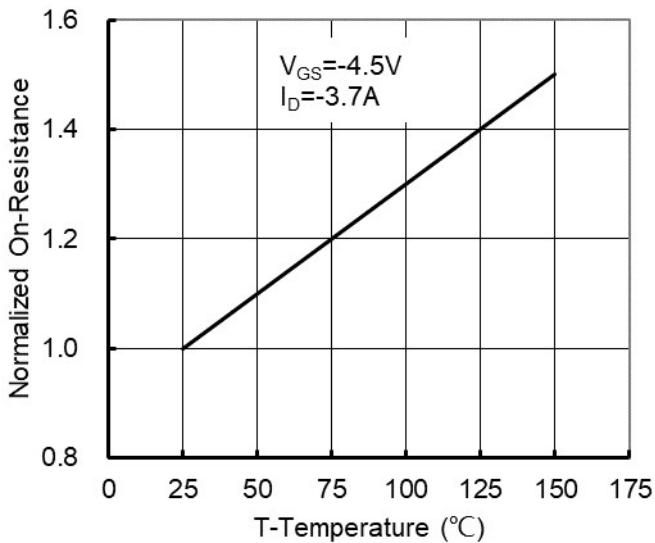


Figure 4: On-Resistance vs. Junction Temperature

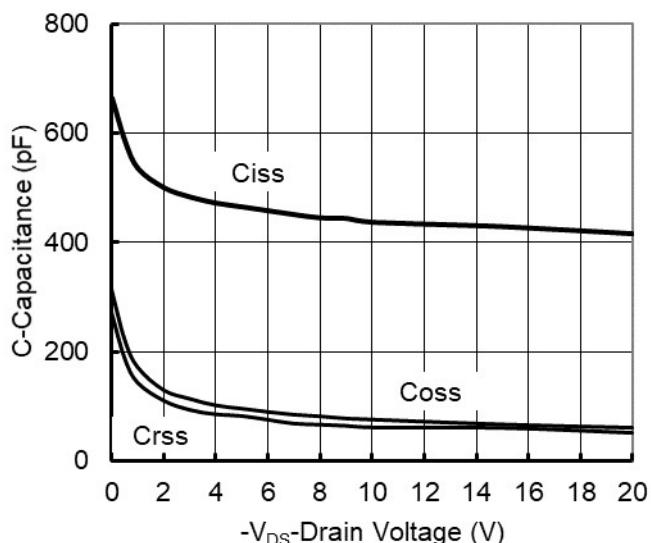


Figure 5. Capacitance Characteristics

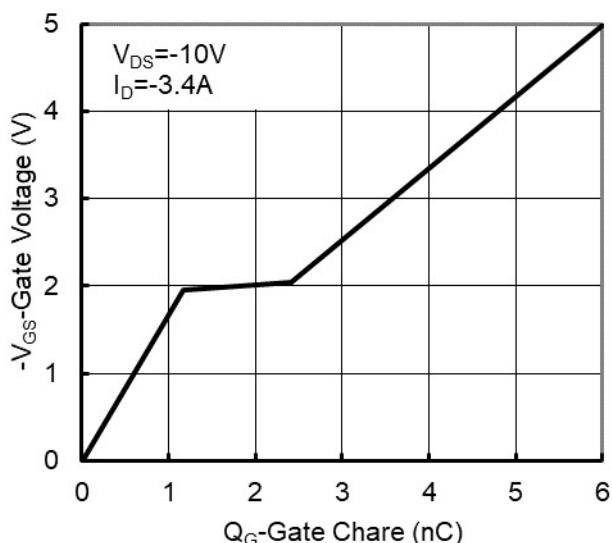
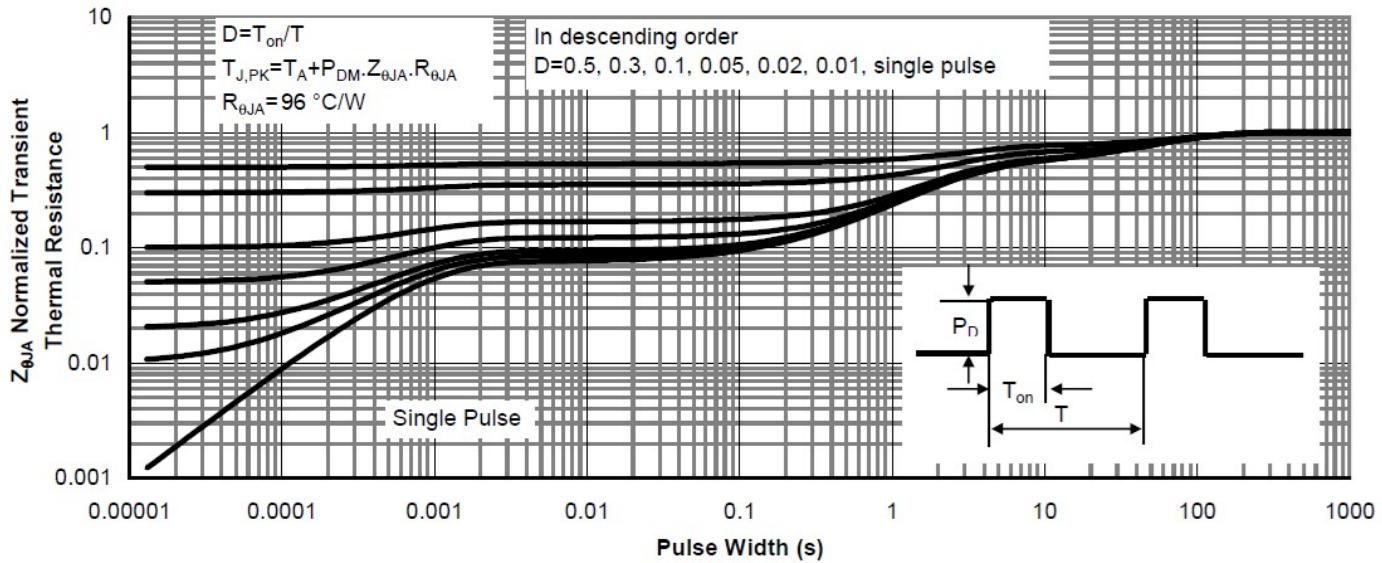
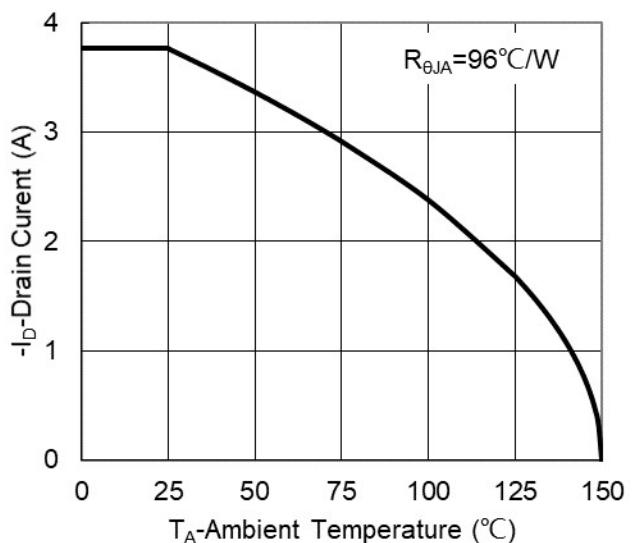
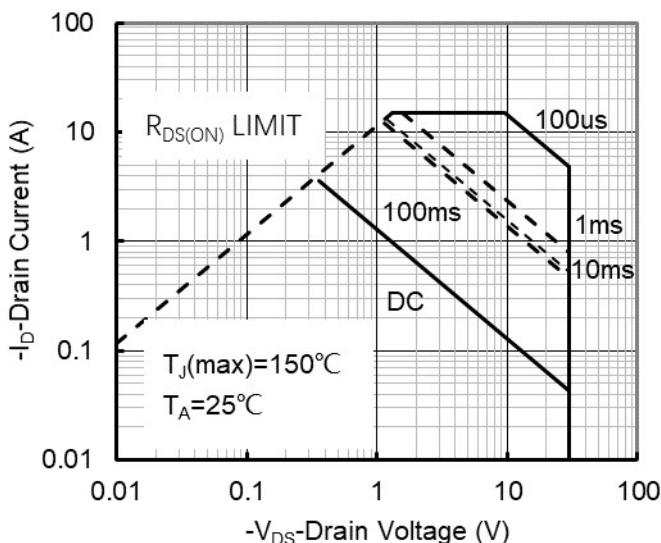
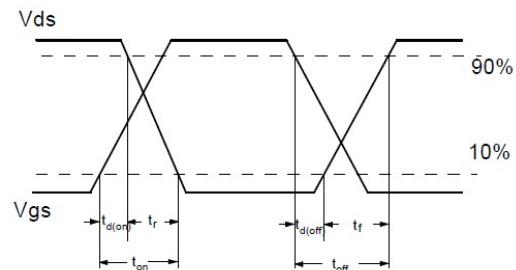
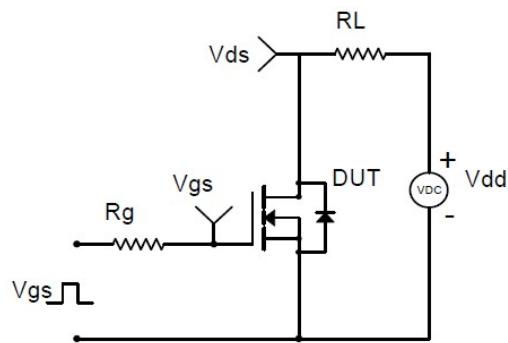
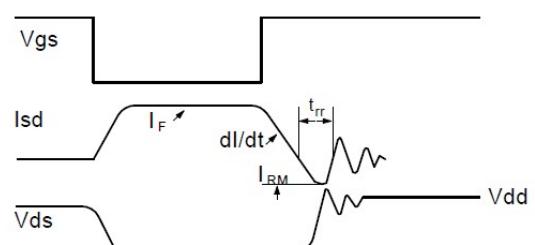
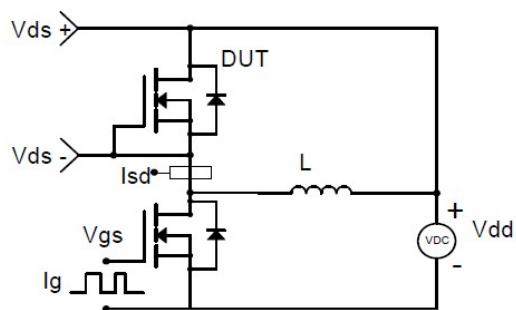


Figure 6. Gate Charge

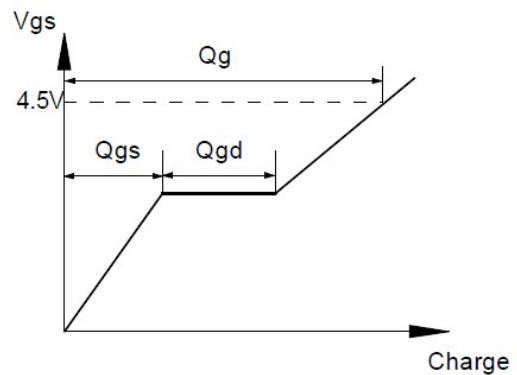
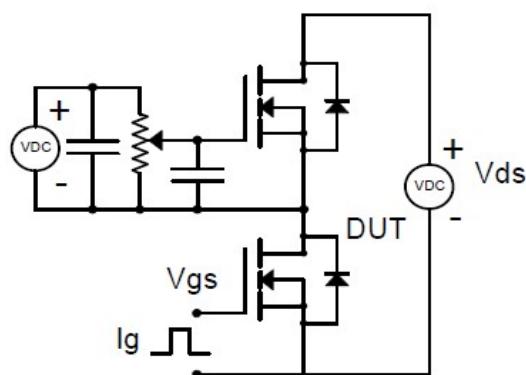




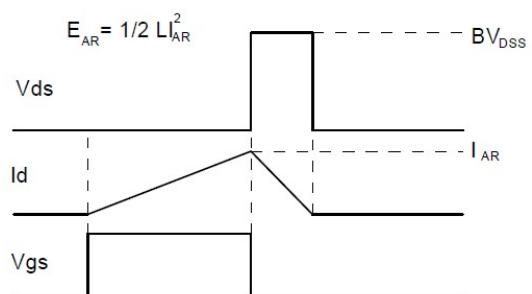
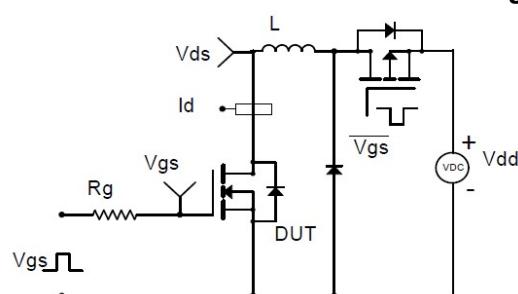
Resistive Switching Test Circuit & Waveforms



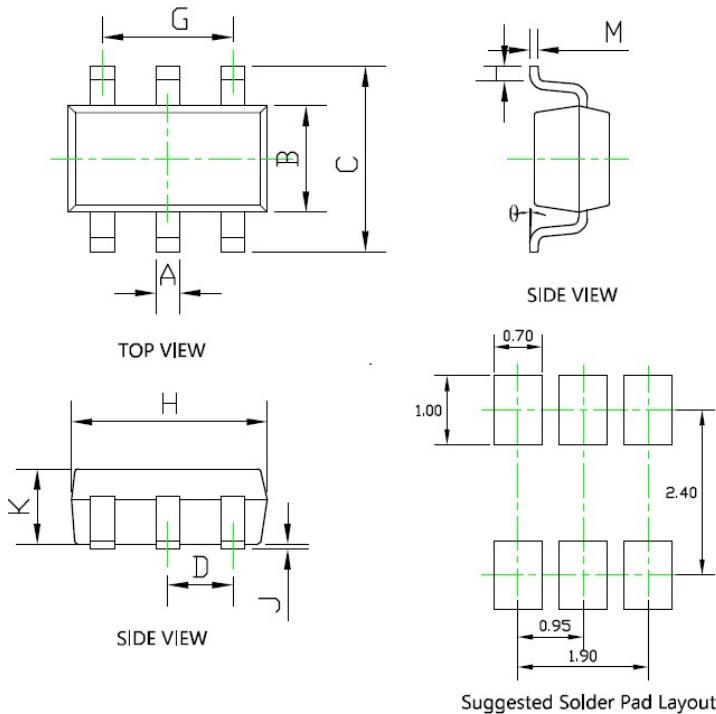
Diode Recovery Test Circuit & Waveforms



Gate Charge Test Circuit & Waveform



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

**■ SOT-23-6L Package information**

SYMBOL	INCHES		Millimeter	
	MIN.	MAX.	MIN.	MAX.
A	0.012	0.020	0.300	0.500
B	0.059	0.067	1.500	1.700
C	0.104	0.116	2.650	2.950
D	0.037BSC		0.950BSC	
G	0.075BSC		1.900BSC	
H	0.111	0.119	2.820	3.020
J	0.000	0.004	0.000	0.100
K	0.041	0.045	1.050	1.150
L	0.012	0.024	0.300	0.600
M	0.004	0.008	0.100	0.200
θ	0°	8°	0°	8°

Note:

1. Controlling dimension in millimeters.
2. General tolerance $\pm 0.05\text{mm}$.
3. The pad layout is for reference purposes only.



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